


<b>Search Notes</b>  	<b>Application/Control No.</b>  10523827	<b>Applicant(s)/Patent Under Reexamination</b>  BIES, RICHARD J.
	<b>Examiner</b>  Ekpo, Nnenna N	<b>Art Unit</b>  2623

SEARCHED			
Class	Subclass	Date	Examiner
725	32, 34-35, 42, 46 and 112	01/29/2008	Nnenna Ekpo

SEARCH NOTES		
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Inventor Name Search	01/29/2008	N. Ekpo
PLUS Search	01/29/2008	N. Ekpo
NPL Search: google	01/29/2008	N. Ekpo
EAST Text Search	01/25, 29/2008	N. Ekpo
Updated EAST Text Search	08/26/2008	Nnenna Ekpo

INTERFERENCE SEARCH			
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